TOSHIBA Field Effect Transistor Silicon N Channel MOS Type (π-MOSV)

2SK3497

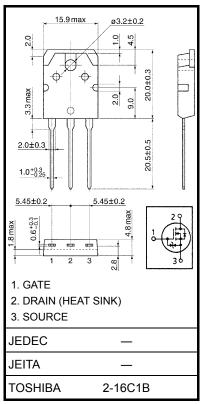
High Power Amplifier Application

Unit: mm

- High breakdown voltage: VDSS = 180V
- Complementary to 2SJ618

Absolute Maximum Ratings (Ta = 25°C)

| Characteristics | | Symbol | Rating | Unit |
|-------------------------------------|----------------|------------------|---------|------|
| Drain-source voltage | | V_{DSS} | 180 | V |
| Gate-source voltage | | V_{GSS} | ±12 | V |
| Drain current | DC (Note 1) | ID | 10 | Α |
| | Pulse (Note 1) | I_{DP} | 30 | Α |
| Drain power dissipation (Tc = 25°C) | | P_{D} | 130 | W |
| Channel temperature | | T _{ch} | 150 | °C |
| Storage temperature range | | T _{stg} | -55~150 | °C |

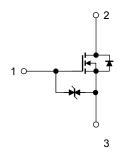


Weight: 4.6 g (typ.)

- Note 1: Ensure that the channel temperature does not exceed 150°C.
- Note 2: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings. Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Thermal Characteristics

| Characteristics | Symbol | Max | Unit |
|--|------------------------|------|------|
| Thermal resistance, channel to case | R _{th (ch-c)} | 0.96 | °C/W |
| Thermal resistance, channel to ambient | R _{th (ch-a)} | 50 | °C/W |





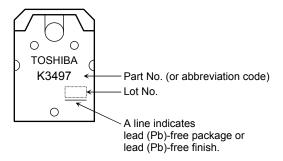
Electrical Characteristics (Ta = 25°C)

| Characteristics | Symbol | Test Condition | Min | Тур. | Max | Unit |
|---------------------------------|----------------------|--|-----|------|------|------|
| Gate leakage current | I _{GSS} | V _{GS} = ±12 V, V _{DS} = 0 V | _ | _ | 10 | μΑ |
| Drain cut-off current | I _{DSS} | V _{DS} = 180V, V _{GS} = 0 V | _ | _ | 100 | μA |
| Drain-source breakdown voltage | V (BR) DSS | I _D = 10 mA, V _{GS} = 0 V | 180 | _ | _ | V |
| Gate threshold voltage | V _{th} | V _{DS} = 10 V, I _D = 1 mA | 1.1 | _ | 2.1 | V |
| Drain-source saturation voltage | V _{DS} (ON) | V _{GS} = 7 V, I _D = 5 A | _ | _ | 0.75 | V |
| Forward transfer admittance | Y _{fs} | V _{DS} = 10 V, I _D = 5 A | 6.0 | 12.0 | _ | S |
| Input capacitance | C _{iss} | | _ | 2400 | _ | |
| Reverse transfer capacitance | C _{rss} | V _{DS} = 30 V, V _{GS} = 0 V, f = 1 MHz | _ | 220 | _ | pF |
| Output capacitance | Coss | | _ | 30 | _ | |

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This transistor is an electrostatic-sensitive device. Please handle with caution.

Marking



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20070701-EN

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